

Search Notes

Application/Control No.

09/634,339

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

KAYE, EVAN JOHN

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	501.1 500.1 514 526	10/4/2006	MK
709	200 202 203	10/4/2006	MK
707	6 102	10/4/2006	MK
84	609 649 668	10/4/2006	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	10/3/2006	MK
NPL (ACM)	10/3/2006	MK
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	10/4/2006	MK